

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/751,534	FRATTI, ROGER A.	
		Examiner	Art Unit	Page 1 of 1
		Sam K. Ahn	2611	

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	RF Micro Device, Inc. Investor Relations <a href="http://www.corporate-ir.net/ireye/ir_site.zhtml?ticker=RFMD&amp;script=410&amp;layout=6&amp;item_id=262277">http://www.corporate-ir.net/ireye/ir_site.zhtml?ticker=RFMD&amp;script=410&amp;layout=6&amp;item_id=262277</a> February 25, 2002
	V	
	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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